Product data sheet

AFSC5G26E38 **Airfast Power Amplifier Module**

– 14 June 2024



General description 1

The AFSC5G26E38 is a fully integrated Doherty power amplifier module designed for wireless infrastructure applications that demand high performance in the smallest footprint. Ideal for applications in massive MIMO systems, outdoor small cells and low power remote radio heads. The field-proven LDMOS power amplifiers are designed for TDD and FDD LTE systems.

Typical performance 2

Table 1. 2496–2690 MHz — Typical LTE Performance

Pout = 6 W Avg., V_{DD} = 28 Vdc, 1 × 20 MHz LTE, Input Signal PAR = 8 dB @ 0.01% Probability on CCDF. (1)

Carrier Center Frequency	Gain (dB)	ACPR (dBc)	PAE (%)
2506 MHz	36.1	-26.6	44.8
2600 MHz	35.4	-30.3	44.9
2680 MHz	34.9	-30.9	44.6

1. All data measured with device soldered in NXP reference circuit.

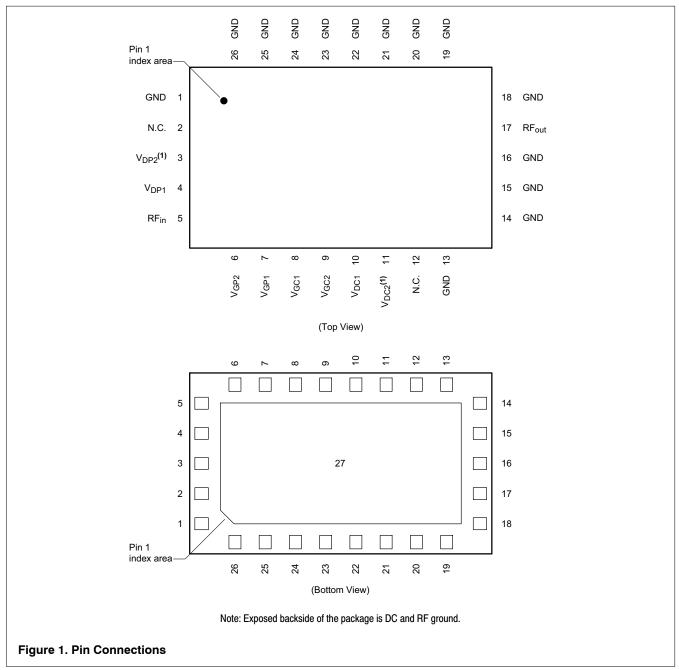
Features and benefits 3

- Frequency: 2496–2690 MHz •
- Advanced high performance in-package Doherty •
- Fully matched (50 ohm input/output, DC blocked) •
- Designed for low complexity analog or digital linearization systems •



4 Pinning information

4.1 Pinning



1. V_{DP2} and V_{DC2} are DC coupled internal to the package and must be powered by a single DC power supply.

Functional pin description 4.2

Table 2. Functional Pin Description

Pin Number	Pin Function	Pin Description
1, 13, 14, 15, 16, 18, 19, 20, 21, 22, 23, 24, 25, 26, 27	GND	Ground
2, 12	N.C.	No Connection
3	V _{DP2}	Peaking Drain Supply, Stage 2
4	V _{DP1}	Peaking Drain Supply, Stage 1
5	RF _{in}	RF Input
6	V _{GP2}	Peaking Gate Supply, Stage 2
7	V _{GP1}	Peaking Gate Supply, Stage 1
8	V _{GC1}	Carrier Gate Supply, Stage 1
9	V _{GC2}	Carrier Gate Supply, Stage 2
10	V _{DC1}	Carrier Drain Supply, Stage 1
11	V _{DC2}	Carrier Drain Supply, Stage 2
17	RF _{out}	RF Output

5 Maximum ratings

Table 3. Maximum Ratings

Rating	Symbol	Value	Unit
Gate-Bias Voltage Range	V _G	–0.5 to +10	Vdc
Operating Voltage Range	V _{DD}	24 to 31	Vdc
Storage Temperature Range	T _{stg}	-65 to +150	°C
Case Operating Temperature	T _C	125	°C
Peak Input Power (2600 MHz, Pulsed CW, 10 μsec(on), 10% Duty Cycle)	P _{in}	30	dBm

6 Lifetime

Table 4. Lifetime

Characteristic	Symbol	Value	Unit
Mean Time to Failure Case Temperature 125°C, 6 W Avg., 32 Vdc	MTTF	> 10	Years

7 ESD protection characteristics

Table 5. ESD Protection Characteristics

Test Methodology	Class
Human Body Model (per JS-001-2017)	1A
Charge Device Model (per JS-002-2014)	C2a

8 Moisture sensitivity level

Table 6. Moisture Sensitivity Level

Test Methodology	Rating	Package Peak Temperature	Unit
Per JESD22-A113, IPC/JEDEC J-STD-020	3	260	°C

9 Electrical characteristics

9.1 DC characteristics

Table 7. DC Characteristics

 $(T_A = 25^{\circ}C \text{ unless otherwise noted})$

Characteristic	Symbol	Тур	Range	Unit
Carrier Stage 1 — On Characteristics				
Gate Threshold Voltage ⁽¹⁾ (V_{DS} = 10 Vdc, I_D = 1.2 μ Adc)	V _{GS(th)}	1.3	±0.4	Vdc
Gate Quiescent Voltage (V _{DS} = 28 Vdc, I _{DQ1A} = 12 mAdc)	V _{GS(Q)}	1.9	±0.4	Vdc
Fixture Gate Quiescent Voltage (V _{DD} = 28 Vdc, I _{DQ1A} = 12 mAdc, Measured in Functional Test)	V _{GG(Q)}	4.9	±1.4	Vdc
Carrier Stage 2 — On Characteristics				
Gate Threshold Voltage (1) (V_{DS} = 10 Vdc, I _D = 12 µAdc)	V _{GS(th)}	1.3	±0.4	Vdc
Gate Quiescent Voltage (V _{DS} = 28 Vdc, I _{DQ2A} = 48 mAdc)	V _{GS(Q)}	1.8	±0.4	Vdc
Fixture Gate Quiescent Voltage (V _{DD} = 28 Vdc, I _{DQ2A} = 48 mAdc, Measured in Functional Test)	V _{GG(Q)}	2.9	±1.2	Vdc
Peaking Stage 1 — On Characteristics ⁽¹⁾		1		
Gate Threshold Voltage (V_{DS} = 10 Vdc, I_D = 1.6 μ Adc)	V _{GS(th)}	1.3	±0.4	Vdc
Gate Quiescent Voltage (V _{DS} = 28 Vdc, I _{DQ1A} = 7 μAdc)	V _{GS(Q)}	1.3	±0.4	Vdc
Fixture Gate Quiescent Voltage $(V_{DD} = 28 \text{ Vdc}, I_{DQ1A} = 7 \mu \text{Adc}, \text{Measured in Functional Test})$	V _{GG(Q)}	1.3	±0.4	Vdc
Peaking Stage 2 — On Characteristics ⁽¹⁾		1		
Gate Threshold Voltage (V_{DS} = 10 Vdc, I_D = 30.4 μ Adc)	V _{GS(th)}	1.3	±0.4	Vdc
Gate Quiescent Voltage (V _{DS} = 28 Vdc, I _{DQ2A} = 24 μAdc)	V _{GS(Q)}	1.2	±0.4	Vdc
Fixture Gate Quiescent Voltage $(V_{DD} = 28 \text{ Vdc}, I_{DQ2A} = 24 \mu \text{Adc}, \text{Measured in Functional Test})$	V _{GG(Q)}	1.2	±0.4	Vdc

1. Each side of device measured separately.

9.2 Functional tests

Table 8. Functional Tests — 2496 MHz (1)

(In NXP Doherty Production ATE ⁽²⁾) Test Fixture, $T_A = 25^{\circ}C$ unless otherwise noted, 50 ohm system) $V_{DD} = 28$ Vdc, $I_{DQ1A} = 12$ mA, $I_{DQ2A} = 48$ mA, $V_{GS1B} = (V_t - 0.350)$ Vdc, $V_{GS2B} = (V_t - 0.400)$ Vdc, $P_{out} = 6$ W Avg., 1-tone CW, f = 2496 MHz.

Characteristic	Symbol	Min	Тур	Мах	Unit
Gain	G	31.0	32.4	_	dB
Drain Efficiency	η _D	39.1	43.0	_	%
P _{out} @ 3 dB Compression Point (Pulsed CW, 5% Duty Cycle)	P3dB	46.0	46.5		dBm

Table 9. Functional Tests — 2690 MHz (1)

(In NXP Doherty Production ATE ⁽²⁾ Test Fixture, $T_A = 25^{\circ}C$ unless otherwise noted, 50 ohm system) $V_{DD} = 28$ Vdc, $I_{DQ1A} = 12$ mA, $I_{DQ2A} = 48$ mA, $V_{GS1B} = (V_t - 0.350)$ Vdc, $V_{GS2B} = (V_t - 0.400)$ Vdc, $P_{out} = 6$ W Avg., 1-tone CW, f = 2690 MHz.

Characteristic	Symbol	Min	Тур	Max	Unit
Gain	G	30.0	32.0	—	dB
Drain Efficiency	η_D	36.8	41.4	—	%
P _{out} @ 3 dB Compression Point (Pulsed CW, 5% Duty Cycle)	P3dB	44.9	45.4	—	dBm

9.3 Wideband ruggedness

Table 10. Wideband Ruggedness (3)

(In NXP Doherty Power Amplifier Module Reference Circuit, $T_A = 25^{\circ}$ C unless otherwise noted, 50 ohm system) $I_{DQ1A} = 12 \text{ mA}$, $I_{DQ2A} = 48 \text{ mA}$, $V_{GSP1} = 1.55 \text{ Vdc}$, $V_{GSP2} = 1.4 \text{ Vdc}$, f = 2600 MHz, Additive White Gaussian Noise (AWGN) with 10 dB PAR

Characteristic	Test Results
ISBW of 400 MHz at 32 Vdc, 6 dB Input Overdrive from 6 W Avg. Modulated Output Power	No Device Degradation

1. Part input and output matched to 50 ohms.

2. ATE is a socketed test environment.

3. All data measured in fixture with device soldered in NXP reference circuit.

AFSC5G26E38

Airfast Power Amplifier Module

9.4 Typical performance

Table 11. Typical Performance (1)

(In NXP Doherty Power Amplifier Module Reference Circuit, $T_A = 25^{\circ}C$ unless otherwise noted, 50 ohm system) $V_{DD} = 28$ Vdc, $I_{DQ1A} = 12$ mA, $I_{DQ2A} = 48$ mA, $V_{GSP1} = 1.55$ Vdc, $V_{GSP2} = 1.4$ Vdc, $P_{out} = 6$ W Avg., 2600 MHz

Characteristic	Symbol	Min	Тур	Max	Unit
VBW Resonance Point, 2-tone, 1 MHz Tone Spacing (IMD Third Order Intermodulation Inflection Point)	VBW _{res}		260		MHz
Quiescent Current Accuracy over Temperature (2) with 2.2 k Ω Gate Feed Resistors (–40 to 85°C) Stage 1 with 2.2 k Ω Gate Feed Resistors (–40 to 85°C) Stage 2	Δl _{QT}		1.0 2.0		%
1–carrier 20 MHz LTE, 8 dB Input Signal PAR	·				
Gain	G		35.4	_	dB
Power Added Efficiency	PAE		44.9	—	%
Adjacent Channel Power Ratio	ACPR	—	-30.3	—	dBc
Adjacent Channel Power Ratio	ALT1		-41.0	—	dBc
Adjacent Channel Power Ratio	ALT2		50.3	—	dBc
Gain Flatness ⁽³⁾	G _F		1.2	_	dB
Fast CW, 27 ms Sweep	·				
Pout @ 3 dB Compression Point	P3dB	—	45.8	—	dBm
AM/PM @ P3dB	Φ	—	-37	—	0
Gain Variation @ Avg. Power over Temperature (-40°C to +105°C)	ΔG		0.038		dB/°C
P3dB Variation over Temperature (-40°C to +105°C)	∆P3dB		0.014		dB/°C

10 Ordering information

Table 12. Ordering Information

Device	Tape and Reel Information	Package
AFSC5G26E38T2	T2 Suffix = 2,000 Units, 24 mm Tape Width, 13-inch Reel	10 mm \times 6 mm Module

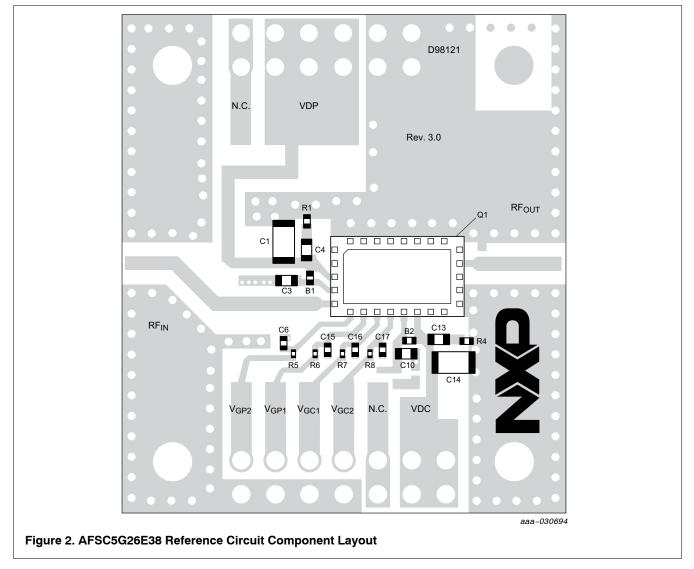
1. All data measured in fixture with device soldered in NXP reference circuit.

2. Refer to AN1977, Quiescent Current Thermal Tracking Circuit in the RF Integrated Circuit Family, and to AN1987, Quiescent Current Control for the RF Integrated Circuit Device Family. Go to http://www.nxp.com/RF and search for AN1977 or AN1987.

3. Gain flatness = $Max(G(f_{Low} \text{ to } f_{High})) - Min(G(f_{Low} \text{ to } f_{High}))$

11 Component layout and parts list

11.1 Component layout



11.2 Component designations and values

Table 13. AFSC5G26E38 Reference Circuit Component Designations and Values

Part	Description	Part Number	Manufacturer
B1, B2	30 Ω Ferrite Bead	BLM15PD300SN1	Murata
C1, C14	10 μF Chip Capacitor	CL31A106KBHNNNE	Samsung
C3, C4, C10, C13	1 μF Chip Capacitor	06035D105KAT2A	AVX
C6, C15, C16, C17	0.1 µF Chip Capacitor GRM155R61H104KE14		Murata
Q1	Power Amplifier Module	AFSC5G26E38	NXP
R1, R4	5.1 Ω, 1/10 W Chip Resistor ERJ-2GEJ5R1X		Panasonic
R5, R6, R7, R8	2.2 kΩ, 1/20 W Chip Resistor ERJ-1GNJ222C Pa		Panasonic
РСВ	Rogers RO4350B, 0.020″, ε _r = 3.66	D98121	MTL

Note: Component numbers C2, C5, C7, C8, C9, C11, C12, R2 and R3 are intentionally omitted.

AFSC5G26E38 Airfast Power Amplifier Module

12 Product marking

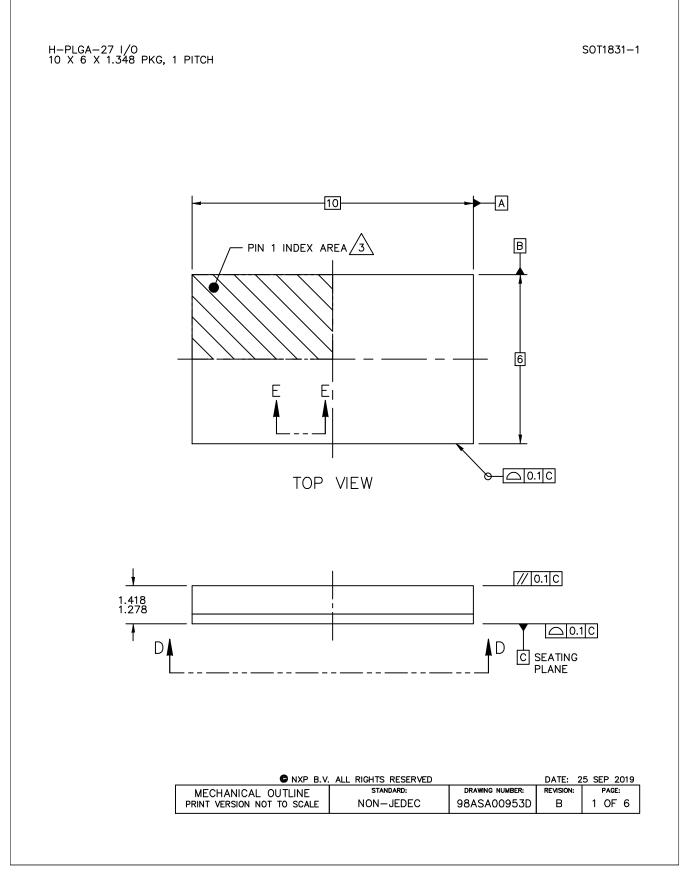


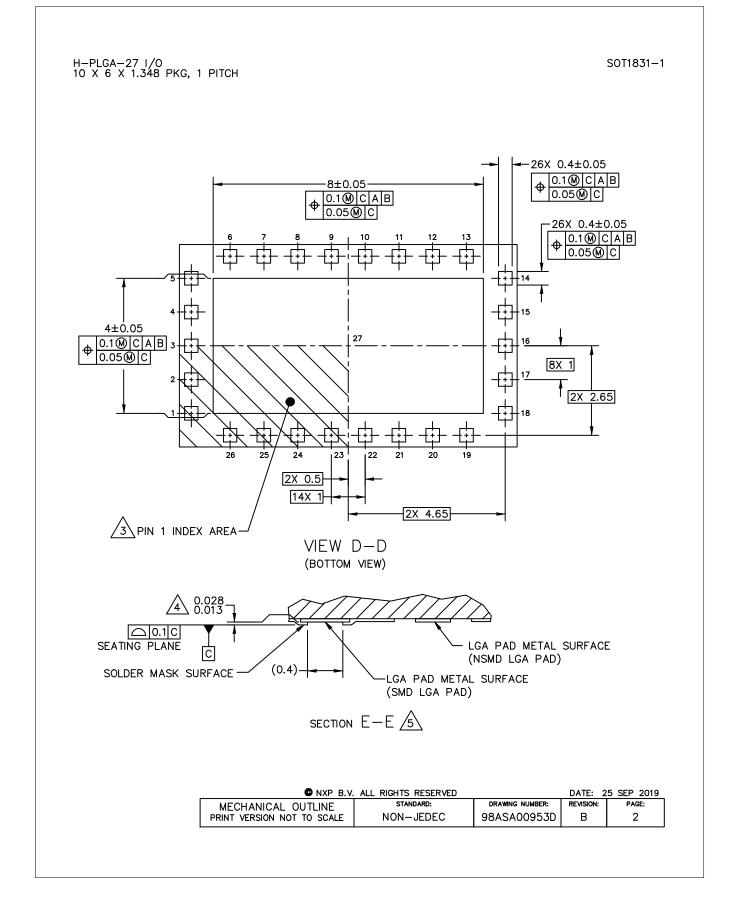
Figure 3. Product Marking

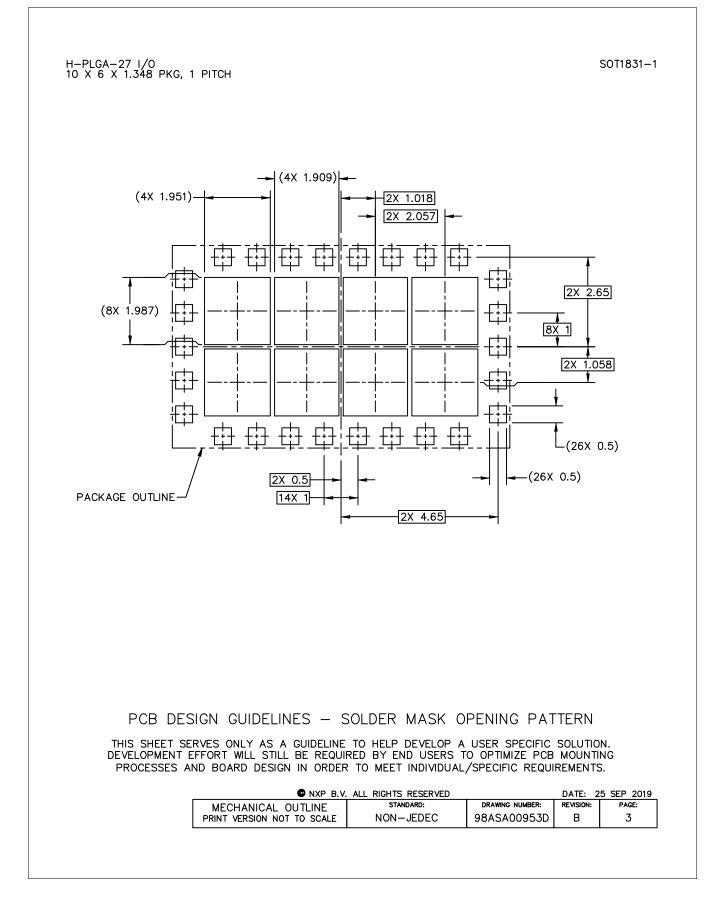
AFSC5G26E38

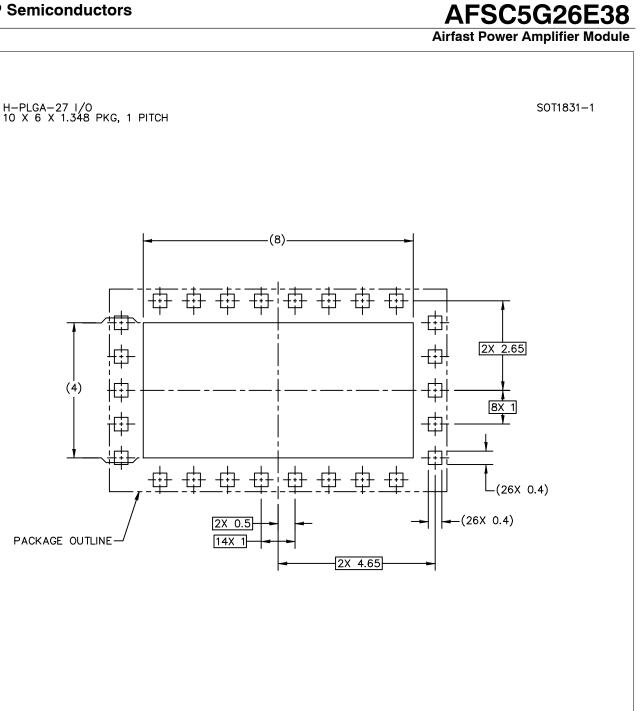
Airfast Power Amplifier Module

13 Package information





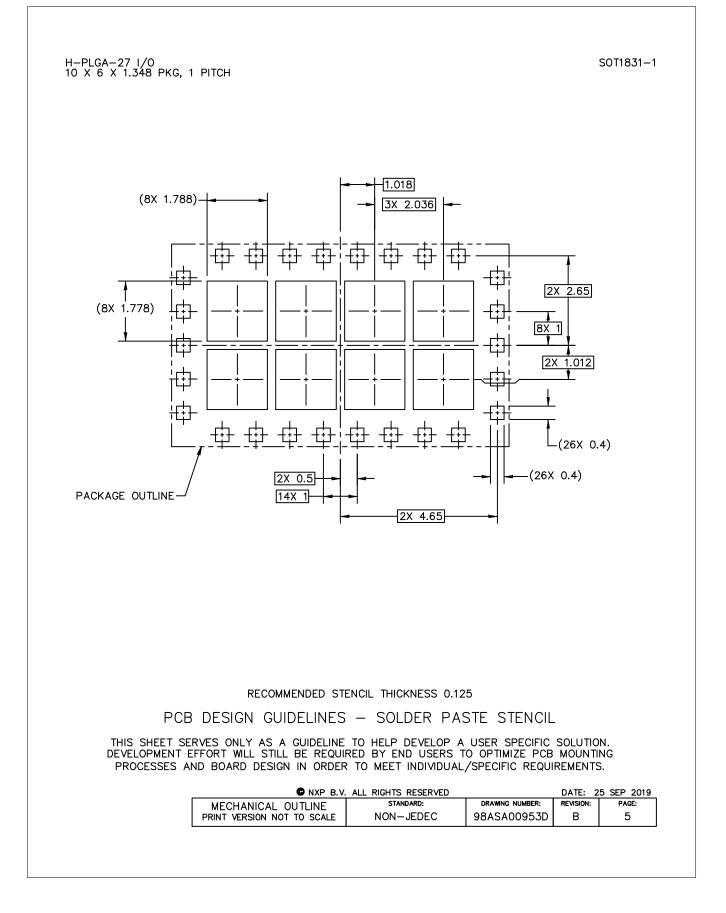




PCB DESIGN GUIDELINES - I/O PADS AND SOLDERABLE AREAS

THIS SHEET SERVES ONLY AS A GUIDELINE TO HELP DEVELOP A USER SPECIFIC SOLUTION. DEVELOPMENT EFFORT WILL STILL BE REQUIRED BY END USERS TO OPTIMIZE PCB MOUNTING PROCESSES AND BOARD DESIGN IN ORDER TO MEET INDIVIDUAL/SPECIFIC REQUIREMENTS.

MECHANICAL OUTLINE	STANDARD:	DRAWING NUMBER:	REVISION:	PAGE:
PRINT VERSION NOT TO SCALE	NON-JEDEC	98ASA00953D	В	4



H-PLGA-27 I/O 10 X 6 X 1.348 PKG, 1	I PITCH			S	60T1831-
NOTES:					
1. ALL DIMENSIONS	IN MILLIMETERS.				
2. DIMENSIONING A	ND TOLERANCING PER ASME	/14.5M—1994.			
3. PIN 1 FEATURE	SHAPE, SIZE AND LOCATION N	MAY VARY.			
	IES TO ALL LEADS AND FLAG				
5. THE BOTTOM VIE	W SHOWS THE SOLDERABLE A K DEFINED. SOME PERIPHERAL DN-SOLDERMASK DEFINED (NS	AREA OF THE PADS. PADS ARE SOLDER	THE CENTER PA MASK DEFINED	D (PIN 2 (SMD) AN	7) 1D
					CED 0010
	MECHANICAL OUTLINE	ALL RIGHTS RESERVED STANDARD:		REVISION:	5 SEP 2019 PAGE:
	PRINT VERSION NOT TO SCALE	NON-JEDEC	98ASA00953D	В	6

AFSC5G26E38

Airfast Power Amplifier Module

14 Product documentation and tools

Refer to the following resources to aid your design process.

Application Notes

- AN1977: Quiescent Current Thermal Tracking Circuit in the RF Integrated Circuit Family
- AN1987: Quiescent Current Control for the RF Integrated Circuit Device Family

Development Tools

Printed Circuit Boards

15 Failure analysis

At this time, because of the physical characteristics of the part, failure analysis is limited to electrical signature analysis. In cases where NXP is contractually obligated to perform failure analysis (FA) services, full FA may be performed by third party vendors with moderate success. For updates contact your local NXP Sales Office.

16 Revision history

The following table summarizes revisions to this document.

Document ID	Release Date	Description
AFSC5G26E38 Rev. 4	14 June 2024	• Tables 8 and 9, Functional Tests, 2496 MHz and 2690 MHz: updated output power test condition, p. 6
AFSC5G26E38 Rev. 3	30 September 2020	 Table 8, Test Circuit Component Designations and Values: updated R5, R6, R7, R8 part number ERJ-1GEJ222C (discontinued) to ERJ-1GNJ222C (replacement component), p. 7 General updates made to align data sheet to current standard
AFSC5G26E38 Rev. 2	29 May 2020	 Table 2. Maximum Ratings, Operating Voltage Range: changed "24 to 30 Vdc" to "24 to 31 Vdc" based on new characterization analysis, p. 4
AFSC5G26E38 Rev. 1	14 February 2020	 Package Outline Drawing: 98ASA00953D package outline update to Rev. B, pp. 9–14 General updates made to align data sheet to current standard
AFSC5G26E38 Rev. 0	23 July 2019	Initial release of product data sheet

Legal information

Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL https://www.nxp.com.

Definitions

Draft — A draft status on a document indicates that the content is still under internal review and subject to formal approval, which may result in modifications or additions. NXP Semiconductors does not give any representations or warranties as to the accuracy or completeness of information included in a draft version of a document and shall have no liability for the consequences of use of such information.

Short data sheet — A short data sheet is an extract from a full data sheet with the same product type number(s) and title. A short data sheet is intended for quick reference only and should not be relied upon to contain detailed and full information. For detailed and full information see the relevant full data sheet, which is available on request via the local NXP Semiconductors sales office. In case of any inconsistency or conflict with the short data sheet, the full data sheet shall prevail.

Product specification — The information and data provided in a Product data sheet shall define the specification of the product as agreed between NXP Semiconductors and its customer, unless NXP Semiconductors and customer have explicitly agreed otherwise in writing. In no event however, shall an agreement be valid in which the NXP Semiconductors product is deemed to offer functions and qualities beyond those described in the Product data sheet.

Disclaimers

Limited warranty and liability — Information in this document is believed to be accurate and reliable. However, NXP Semiconductors does not give any representations or warranties, expressed or implied, as to the accuracy or completeness of such information and shall have no liability for the consequences of use of such information. NXP Semiconductors takes no responsibility for the content in this document if provided by an information source outside of NXP Semiconductors.

In no event shall NXP Semiconductors be liable for any indirect, incidental, punitive, special or consequential damages (including – without limitation – lost profits, lost savings, business interruption, costs related to the removal or replacement of any products or rework charges) whether or not such damages are based on tort (including negligence), warranty, breach of contract or any other legal theory.

Notwithstanding any damages that customer might incur for any reason whatsoever, NXP Semiconductors' aggregate and cumulative liability towards customer for the products described herein shall be limited in accordance with the Terms and conditions of commercial sale of NXP Semiconductors.

Right to make changes — NXP Semiconductors reserves the right to make changes to information published in this document, including without limitation specifications and product descriptions, at any time and without notice. This document supersedes and replaces all information supplied prior to the publication hereof.

Suitability for use — NXP Semiconductors products are not designed, authorized or warranted to be suitable for use in life support, life-critical or safety-critical systems or equipment, nor in applications where failure or malfunction of an NXP Semiconductors product can reasonably be expected to result in personal injury, death or severe property or environmental damage. NXP Semiconductors and its suppliers accept no liability for inclusion and/or use of NXP Semiconductors products in such equipment or applications and therefore such inclusion and/or use is at the customer's own risk. **Applications** — Applications that are described herein for any of these products are for illustrative purposes only. NXP Semiconductors makes no representation or warranty that such applications will be suitable for the specified use without further testing or modification.

AFSC5G26E38 Airfast Power Amplifier Module

Customers are responsible for the design and operation of their applications and products using NXP Semiconductors products, and NXP Semiconductors accepts no liability for any assistance with applications or customer product design. It is customer's sole responsibility to determine whether the NXP Semiconductors product is suitable and fit for the customer's applications and products planned, as well as for the planned application and use of customer's third party customer(s). Customers should provide appropriate design and operating safeguards to minimize the risks associated with their applications and products.

NXP Semiconductors does not accept any liability related to any default, damage, costs or problem which is based on any weakness or default in the customer's applications or products, or the application or use by customer's third party customer(s). Customer is responsible for doing all necessary testing for the customer's applications and products using NXP Semiconductors products in order to avoid a default of the applications and the products or of the application or use by customer's third party customer(s). NXP does not accept any liability in this respect.

Limiting values — Stress above one or more limiting values (as defined in the Absolute Maximum Ratings System of IEC 60134) will cause permanent damage to the device. Limiting values are stress ratings only and (proper) operation of the device at these or any other conditions above those given in the Recommended operating conditions section (if present) or the Characteristics sections of this document is not warranted. Constant or repeated exposure to limiting values will permanently and irreversibly affect the quality and reliability of the device.

Terms and conditions of commercial sale — NXP Semiconductors products are sold subject to the general terms and conditions of commercial sale, as published at https://www.nxp.com/profile/terms, unless otherwise agreed in a valid written individual agreement. In case an individual agreement is concluded only the terms and conditions of the respective agreement shall apply. NXP Semiconductors hereby expressly objects to applying the customer's general terms and conditions with regard to the purchase of NXP Semiconductors products by customer.

No offer to sell or license — Nothing in this document may be interpreted or construed as an offer to sell products that is open for acceptance or the grant, conveyance or implication of any license under any copyrights, patents or other industrial or intellectual property rights.

Export control — This document as well as the item(s) described herein may be subject to export control regulations. Export might require a prior authorization from competent authorities.

Suitability for use in non-automotive qualified products — Unless this document expressly states that this specific NXP Semiconductors product is automotive qualified, the product is not suitable for automotive use. It is neither qualified nor tested in accordance with automotive testing or application requirements. NXP Semiconductors accepts no liability for inclusion and/or use of non-automotive qualified products in automotive equipment or applications.

AFSC5G26E38 Airfast Power Amplifier Module

In the event that customer uses the product for design-in and use in automotive applications to automotive specifications and standards, customer (a) shall use the product without NXP Semiconductors' warranty of the product for such automotive applications, use and specifications, and (b) whenever customer uses the product for automotive applications beyond NXP Semiconductors' specifications such use shall be solely at customer's own risk, and (c) customer fully indemnifies NXP Semiconductors for any liability, damages or failed product claims resulting from customer design and use of the product for automotive applications beyond NXP Semiconductors' standard warranty and NXP Semiconductors' product specifications.

Translations — A non–English (translated) version of a document, including the legal information in that document, is for reference only. The English version shall prevail in case of any discrepancy between the translated and English versions.

Security — Customer understands that all NXP products may be subject to unidentified vulnerabilities or may support established security standards or specifications with known limitations. Customer is responsible for the design and operation of its applications and products throughout their lifecycles to reduce the effect of these vulnerabilities on customer's applications and products. Customer's responsibility also extends to other open and/or proprietary technologies supported by NXP products for use in customer's applications. NXP accepts no liability for any vulnerability. Customer should regularly check security updates from NXP and follow up appropriately.

Customer shall select products with security features that best meet rules, regulations, and standards of the intended application and make the ultimate design decisions regarding its products and is solely responsible for compliance with all legal, regulatory, and security related requirements concerning its products, regardless of any information or support that may be provided by NXP.

NXP has a Product Security Incident Response Team (PSIRT) (reachable at PSIRT@nxp.com) that manages the investigation, reporting, and solution release to security vulnerabilities of NXP products.

NXP B.V. — NXP B.V. is not an operating company and it does not distribute or sell products.

Trademarks

Notice: All referenced brands, product names, service names, and trademarks are the property of their respective owners.

NXP — wordmark and logo are trademarks of NXP B.V.

Airfast — is a trademark of NXP B.V.

Freescale — is a trademark of NXP B.V.

Please be aware that important notices concerning this document and the product(s) described herein, have been included in section 'Legal information'.

© 2024 NXP B.V.

All rights reserved.

For more information, please visit: https://www.nxp.com

com Document feedback Date of release: 14 June 2024 Document identifier: AFSC5G26E38

Mouser Electronics

Authorized Distributor

Click to View Pricing, Inventory, Delivery & Lifecycle Information:

NXP:

AFSC5G26E38-EVB AFSC5G26E38T2